

PRODUCT SPECIFICATION SHEET

CUSTOMER :
PRODUCT TYPE : SMD X'TAL 3.2*2.5(4PAD)
NOMINAL FREQ. : 26.000000 MHz
FL P/N : 3S26000361
REVISION : S0
CUSTOMER P/N :

CUSTOMER'S APPROVAL&DATE

FL CORPORATION

APPROVED	CHECKED	DESIGNED
Jay Lee	Jin Qi	Chen XuanRu

MSL1
RoHS Compliant



CONTENTS

PAGE

- SPECIFICATION REVISION RECORD SHEET	2
- ELECTRICAL SPECIFICATIONS	3
- DIMENSIONS & MARKING	4
- STRUCTURE ILLUSTRATION	5
- RELIABILITY TEST SPECIFICATIONS	6
- PACKAGING REQUIREMENT	7/8
- SPECIFICATION OF THE ENVIRONMENT-RELATED SUBSTANCES	9

ATTACHMENT (optional)

- ELECTRICAL CHARACTERISTICS TEST	A <input type="checkbox"/>	YES <input checked="" type="checkbox"/>	NO
- TEMPERATURE CHARACTERISTICS TEST	B <input type="checkbox"/>	YES <input checked="" type="checkbox"/>	NO



PRODUCT DESCRIPTION

Standard atmospheric conditions

Unless otherwise specified. The standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature : $25\pm 2^{\circ}\text{C}$
Relative humidity 40%~70%

If there is no doubt the results, measurement shall be made within the following limits:

Ambient temperature : $25\pm 2^{\circ}\text{C}$
Relative humidity : 40%~70%

Measure equipment

Electrical characteristics measured by S&A250B or equivalent.

Crystal cutting type

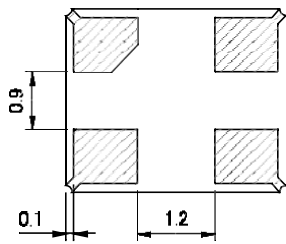
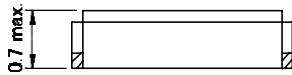
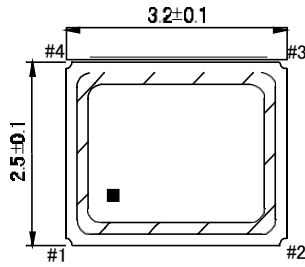
The crystal is using AT CUT (thickness shear mode)

ELECTRICAL SPECIFICATIONS

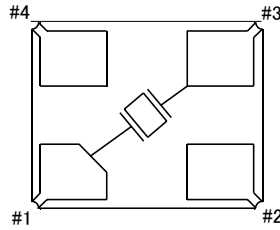
No.	Items	Electrical Spec.					Remarks
		Symbol	Min	Typ	Max	Units	
1	Nominal Frequency	FL	26.000000			MHz	-
2	Oscillation Mode	-	Fundamental			-	-
3	Load Capacitance	CL	9.0			pF	-
4	Frequency Tolerance	-	± 10			ppm	at $25\pm 2^{\circ}\text{C}$
5	Frequency Stability	-	± 15			ppm	at $-40\sim +85^{\circ}\text{C}$ (reference 25°C)
6	Shunt Capacitance	C0	-	-	3	pF	
7	Aging (/1 year)	-	± 3			ppm/year	at $25\pm 2^{\circ}\text{C}$
8	Operating Temperature	-	-40		85	$^{\circ}\text{C}$	-
9	Storage Temperature	-	-40		85	$^{\circ}\text{C}$	-
10	Equivalent series resistance	ESR	-		30	ohms	-
11	Insulation Resistance	IR	500	-	-	M-ohms	at DC 100V
12	Drive Level	DL			100	uW	-



DIMENSIONS unit:mm

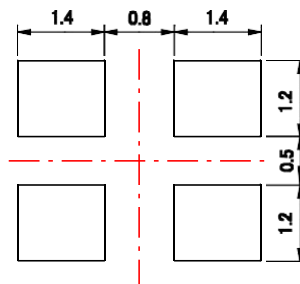


CONNECTION DIAGRAM (TOP VIEW)

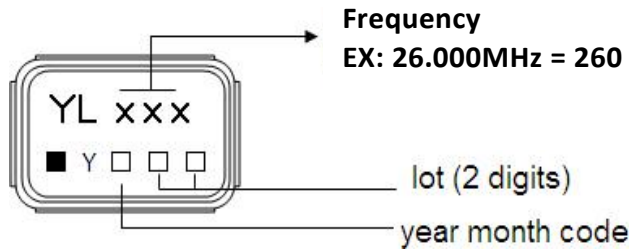


Pin	Function
#1	Xtal terminal (Input)
#2	GND terminal
#3	Xtal terminal (Output)
#4	GND terminal

LAND PATTERN unit:mm



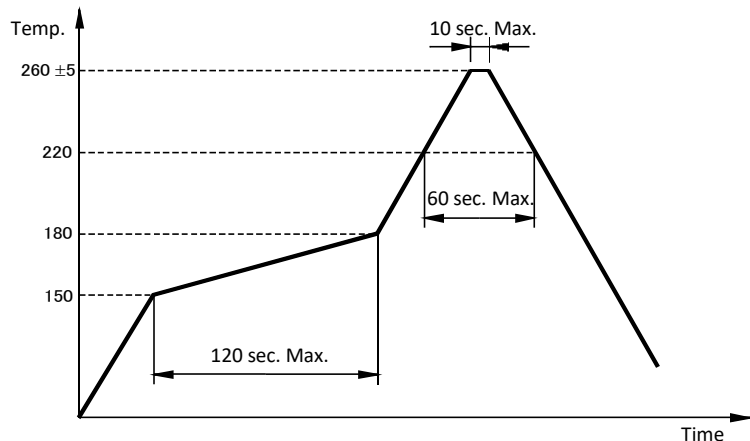
MARKING



month year	month											
	JAN	FEB	MAR	APR	MAY	JUN	JUL	AUG	SEP	OCT	NOV	DEC
2017 2021	A	B	C	D	E	F	G	H	J	K	L	M
2018 2022	N	P	Q	R	S	T	U	V	W	X	Y	Z
2019 2023	a	b	c	d	e	f	g	h	j	k	l	m
2020 2024	n	p	q	r	s	t	u	v	w	x	y	z

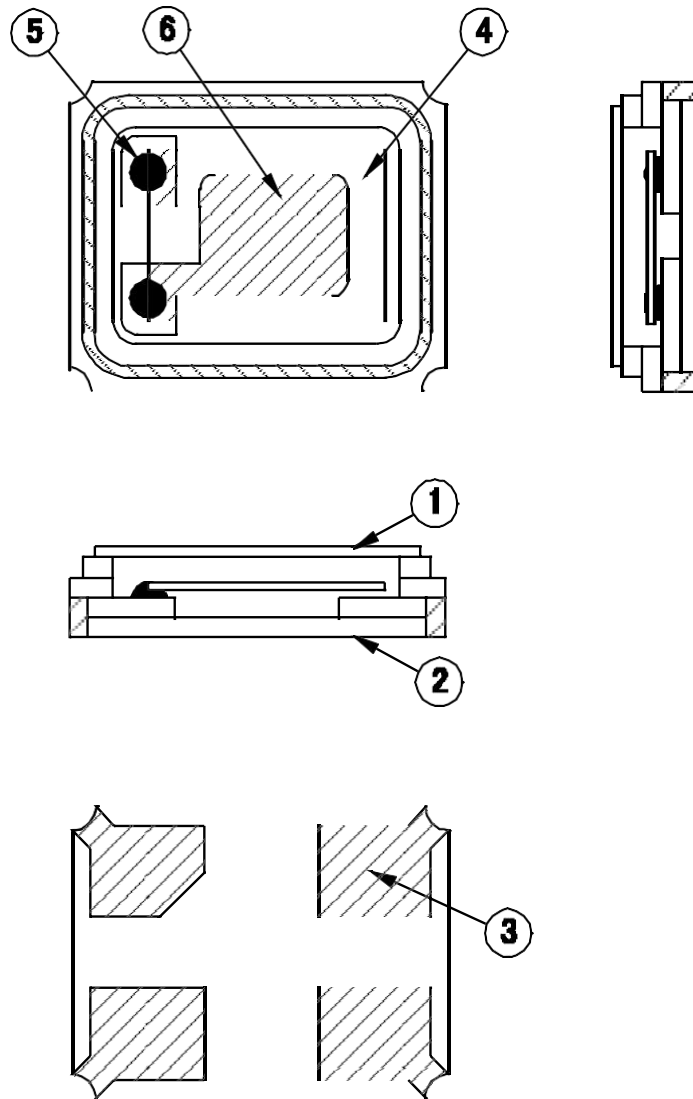
SUGGESTED REFLOW PROFILE

Total time : 360 sec. Max.
 Solder melting point : 225 °C





STRUCTURE ILLUSTRATION



NO	COMPONENTS	MATERIALS	QTY	FINISH/SPECIFICATIONS
1	Cap(Lid)	Kovar(Fe+Co+Ni)	1	Ni plating
2	Base(Package)	Almina Ceramics (Al ₂ O ₃)	1	
3	Pad(Package)	Ni + Au	4	Ni+Au plating
4	Crystal blank	SiO ₂	1	-
5	Conductive adhesive	Ag	2	Silicone resin
6	Electrode	Noble metal	2	-

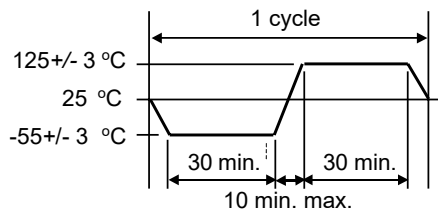


RELIABILITY SPECIFICATIONS

1. MECHANICAL ENDURANCE

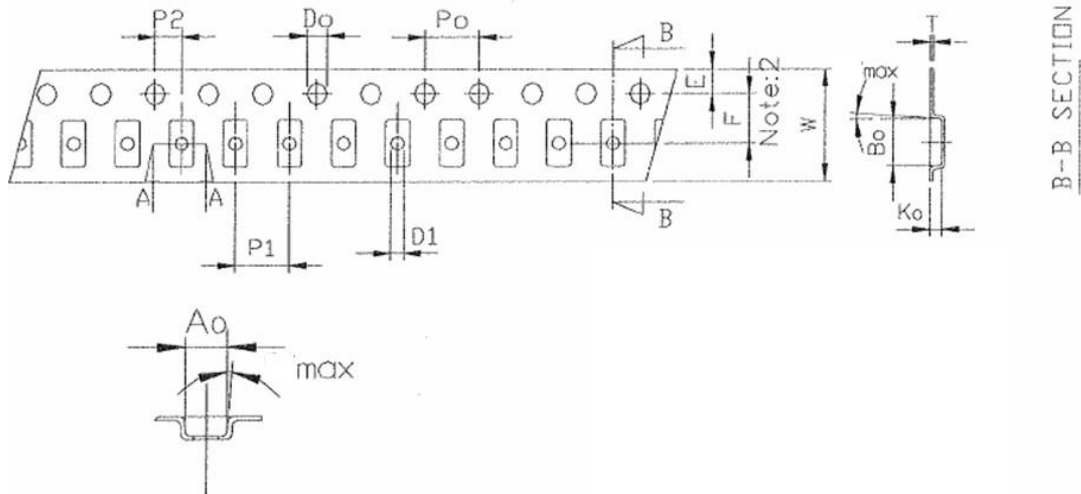
No.	Test Item	Test Methods	
1	Drop Test	150 cm height, fall freely onto stainless plate 3 times. JIS C6701	
2	Shock Test	150g/150cm Height, 3 times in the direction of $\pm x$, $\pm y$, $\pm z$ on concrete floor IEC-68-02-27	
3	Mechanical Shock	Device are shocked to half sine wave (1000 G) three mutually perpendicular axes each 3 times. 1.0m sec. duration time MIL-STD-202F	
4	Vibration	Frequency range 10 ~ 55 Hz Amplitude 1.52 mm Perpendicular axes each test time 2 hours (x,y,z Axis) Total test time 6 hours MIL-STD-883E	
5	Gross Leak	Standard Sample For Automatic Gross Leak Detector Test Pressure 2kg/cm ² MIL-STD-883E	
6	Fine Leak	Helium Bombing 4.5kgf/cm ² for 2 hr MIL-STD-883E	
7	Solderability	Temperature 245 °C +/- 5 °C Immersing depth 0.5 mm minimum Immersion time 10 +/- 0.5 seconds Flux Rosin resin methyl alcohol solvent (1 : 4) MIL-STD-883E	
8	Resistance To Soldering Heat	Pre-heat temperature 125 °C Pre-heat time 60 ~ 120 sec. Test temperature 260 +/- 5 °C Test time 5 +/- 1 sec. MIL-STD-202F	

2. ENVIRONMENTAL ENDURANCE

No.	Test Item	Test Methods	
9	High Temp. Storage	+ 125 °C +/- 3 °C for 500 +/- 12 hours	
10	Low Temp. Storage	- 40 °C +/- 3 °C for 500 +/- 12 hours	
11	Thermal Shock	Total 100 cycles of the following temperature cycle  MIL-STD-883E	
12	High Temp&Humidity	85 °C ± 3 °C, RH 85%, 500Hrs JIS C5023	



PACKING : (EIA-481-2)



Dimension PKG Type	Unit : mm						
	A0	B0	K0	T	W	E	F
3225(8mm)	2.70±0.1	3.40±0.1	1.4±0.1	0.25±0.5	8±0.3	1.75±0.2	3.50±0.1
	P1	P2	D1	D0	P0		
	4±0.1	2±0.1	1±0.05	1.55±0.05	4±0.1		

Standard Reel Quantity is 3,000 pcs per reel.

THE INSPECTION FOR TAPE TENSION


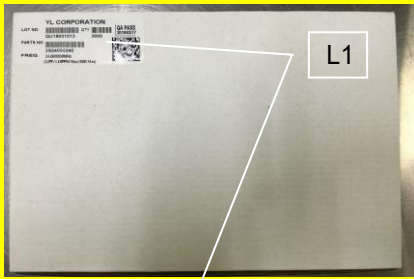


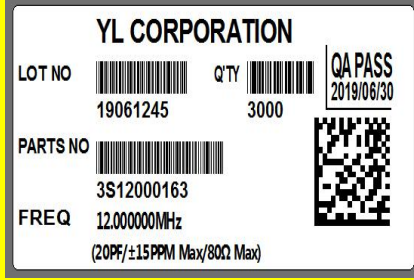

ITEM		Defect	Method
Appearance	ALL	1.The tape is not coincidence 2.The bubble	Visual inspection
Tape Tension	8045、7050 6035-12mm 5032-12mm 3225-12mm	overstep 61±6g(55~67g)	Pull test
	3225-8mm	overstep 40±5g(35~45g)	
	2520-8mm	overstep 55±6g(49~61g)	
	2016-8mm	overstep 34±6g(28~40g)	
	1612-8mm	overstep 34±6g(28~40g)	
	6035-16mm 5032-16mm	overstep 60±6g(54~66g)	

REMARK : NA

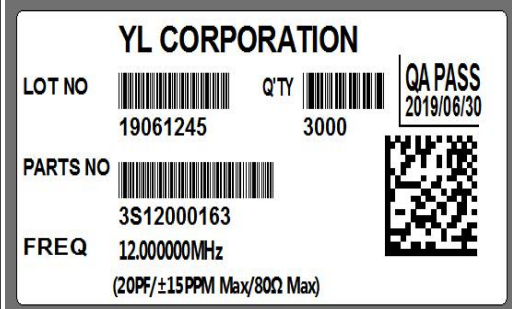


SMD PRODUCT PACKING STANDARD

Out-going packing instruction

Reel Packing	Inner Packing	Carton
name: reel standard: diameter 18cm material: plastics	name: inner box standard: L19.0xW19.0xH2.5cm material: B corrugated paper	name: carton standard: L34.0xW22.0xH22.0cm material: AB corrugated paper(10 boxes enter)
		
		

The label instruction

Label Drawing	Mark	Name of Article	Spec.	Size	Printing
	L1	条码标签 Bar Code Label (Chintz Paper)	1.Date Code 2.Lot No. 3.Part No. 4.Freq 5.Q'ty	75x35mm	White

Remark

Specifications on the label is for the use of templates with different product specifications may vary.
 If customer specified requirements for labels packaging. please provide the operation procedure.



Range	Products	Packing Material
Banned Substances	Maximum concentration ppm(mg/kg)	Maximum concentration ppm(mg/kg)
1.镉及镉化合物 Cadmium and cadmium compounds	100	100
2.铅及铅化合物 Lead and lead compounds	1000	100
3.汞及汞化合物 Mercury and mercury compounds	1000	100
4.六价铬化合物 Hexavalent-Chromium VI (Cr+6)	1000	100
5. 聚 溴 联 苯 PBB Polybrominated biphenyls	1000	N/A
6. 聚 溴 二 苯 醚 PBDE Polybrominated diphenyl ethers	1000	N/A
7.邻苯二甲酸二(2-乙基己基)酯 DEHP Di (2-ethylhexyl) phthalate	1000	N/A
8.邻苯二甲酸丁苄酯 BBP Butyl Benzyl Phthalate	1000	N/A
9.邻苯二甲酸二丁酯 DBP Dibutyl Phthalate	1000	N/A
10 邻苯二甲酸二异丁酯 DIBP Diisobutyl Phthalate	1000	N/A
11. 氟 (F)、氯 (Cl)、溴 (Br)、碘 (I) Fluorine、Chlorine、 Bromine、Iodine	900、900、900、900 注: Br+Cl<1000	N/A
12.包装材料中重金属(汞、镉、六价铬、铅、PBB、PBDE)之总量 Heavy metals (mercury, cadmium, lead, Cr+6,PBB and PBDE) in packing materials	N/A	100 铅(Pb) + 镉(Cd) + 汞(Hg) + 六价铬 (Cr+6) <100ppm
13.高度关注物质 SVHC-Substances of Very High Concern	1000	N/A



X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for [Crystals](#) category:

Click to view products by [Failong Crystal](#) manufacturer:

Other Similar products are found below :

[CX3225GB25000M0PPSZ1](#) [718-13.2-1](#) [MC405 32.0000K-R3:PURE SN](#) [7A-40.000MAAE-T](#) [FL2000085](#) [99-BU](#) [9B-15.360MBBK-B](#) [9C-7.680MBBK-T](#) [H10S-12.000-18-EXT-TR](#) [ABC2-6.000MHZ-D4Z-T](#) [ABLS-20.000MHZ-D2-T](#) [ABS071-32.768KHZ-6-T](#) [R38-32.768-12.5-5PPM-NPB](#) [BTD1062E05A-513](#) [21U15A-21.4MHZ](#) [RTX-781DF1-S-20.950](#) [LFXTAL066198Cutt](#) [9C-14.31818MBBK-T](#) [A-11.000MHZ-27](#) [ABL-27.000MHZ-B4Y-T](#) [ABM11-132-24.000MHZ-T3](#) [ABM3B1-25.000MHZ-D2Y-T](#) [SPT2A-.032768B](#) [SPT2A.032768G](#) [SSPT7F-9PF20-R](#) [FX325BS-38.88EEM1201](#) [LFXTAL065253Cutt](#) [LFXTAL066431Cutt](#) [XT9S20ANA14M7456](#) [XT9SNLANA16M](#) [7A-24.576MBBK-T](#) [7B-30.000MBBK-T](#) [MMCC2R32.7680KHZ](#) [7A-14.31818MBBK-T](#) [6504-202-1501](#) [6526-202-1501](#) [ABLS-12.000MHZ-B2Y-T](#) [7A-10.000MBBK-T](#) [SG636PCE-20.000MC](#) [3404](#) [E1SAA18-25.000M TR](#) [CM315D32768EZFT](#) [C1E-24.000-7-2020-R](#) [C1E-19.200-12-1530-X-R](#) [C1E-16.000-12-1530-X-R](#) [ABM11-16.000MHZ-9-B1U-T](#) [FL5000014](#) [EUCA18-3.1872M](#) [FX0800015](#) [425F35E027M0000](#)